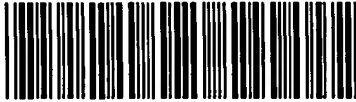


Search Notes

Application/Control No.

10/643,052

Examiner

Drew E. Becker

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

1794

SEARCHED

Class	Subclass	Date	Examiner
Search updated		11/26/07	DE-7

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR